## **Power MOSFET** 25 V, 78 A, Single N–Channel, DPAK

#### Features

- Low R<sub>DS(on)</sub>
- Optimized Gate Charge
- Pb–Free Packages are Available

#### Applications

- Desktop VCORE
- DC–DC Converters
- Low Side Switch

#### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

				,	
Parame	eter		Symbol	Value	Unit
Drain-to-Source Voltage	V <sub>DSS</sub>	25	V		
Gate-to-Source Voltage			$V_{GS}$	$\pm 20$	V
Continuous Drain		$T_C = 25^{\circ}C$	I <sub>D</sub>	14.8	А
Current (Note 1)		$T_C = 85^{\circ}C$		11.5	
Power Dissipation (Note 1)		$T_C = 25^{\circ}C$	PD	2.3	W
Continuous Drain		$T_C = 25^{\circ}C$	Ι <sub>D</sub>	11.4	А
Current (Note 2)	Steady	$T_{C} = 85^{\circ}C$		8.8	
Power Dissipation (Note 2)	State	$T_C = 25^{\circ}C$	P <sub>D</sub>	1.4	W
Continuous Drain		$T_C = 25^{\circ}C$	Ι <sub>D</sub>	78	А
Current (R <sub>0JC</sub> )		T <sub>C</sub> = 85°C		56	
Power Dissipation $(R_{\theta JC})$		$T_C = 25^{\circ}C$	PD	64	W
Pulsed Drain Current	t <sub>p</sub> =	= 10 μs	I <sub>DM</sub>	210	А
Current Limited by Package $T_A = 25^{\circ}C$			I <sub>DmaxPkg</sub> 45		А
Drain to Source dV/dt	Drain to Source dV/dt			8.0	V/ns
Operating Junction and S	Storage To	emperature	T <sub>J</sub> , T <sub>stg</sub>	-55 to 175	°C
Source Current (Body D	iode)		IS	78	А
Single Pulse Drain-to-S Energy ( $V_{DD} = 24 V$ , $V_{G}$ L = 5.0 mH, $I_L(pk) = 17 P$	<sub>S</sub> = 10 V,		E <sub>AS</sub>	722.5	mJ
Lead Temperature for So (1/8" from case for 10 so	Lead Temperature for Soldering Purposes (1/8" from case for 10 seconds)			260	°C

#### THERMAL RESISTANCE

Junction-to-Case (Drain)	$R_{\thetaJC}$	1.95	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\thetaJA}$	65	
Junction-to-Ambient - Steady State (Note 2)	$R_{\thetaJA}$	110	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).

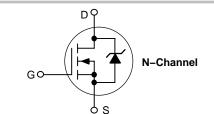
2. Surface-mounted on FR4 board using the minimum recommended pad size.

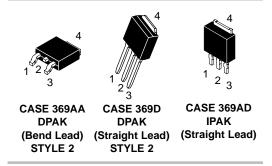


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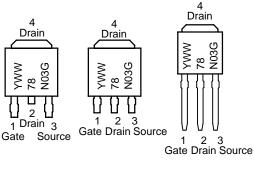
#### http://onsemi.com

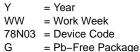
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> TYP	I <sub>D</sub> MAX
25 V	4.6 @ 10 V	78 A
25 V	6.5 @ 4.5 V	107





## MARKING DIAGRAMS & PIN ASSIGNMENTS





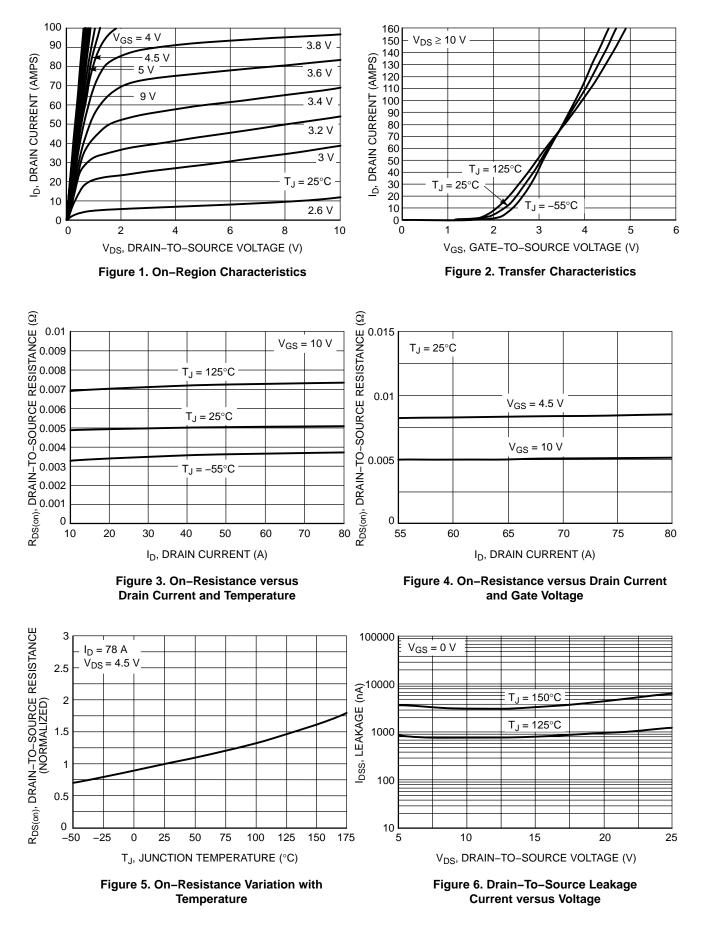
#### **ORDERING INFORMATION**

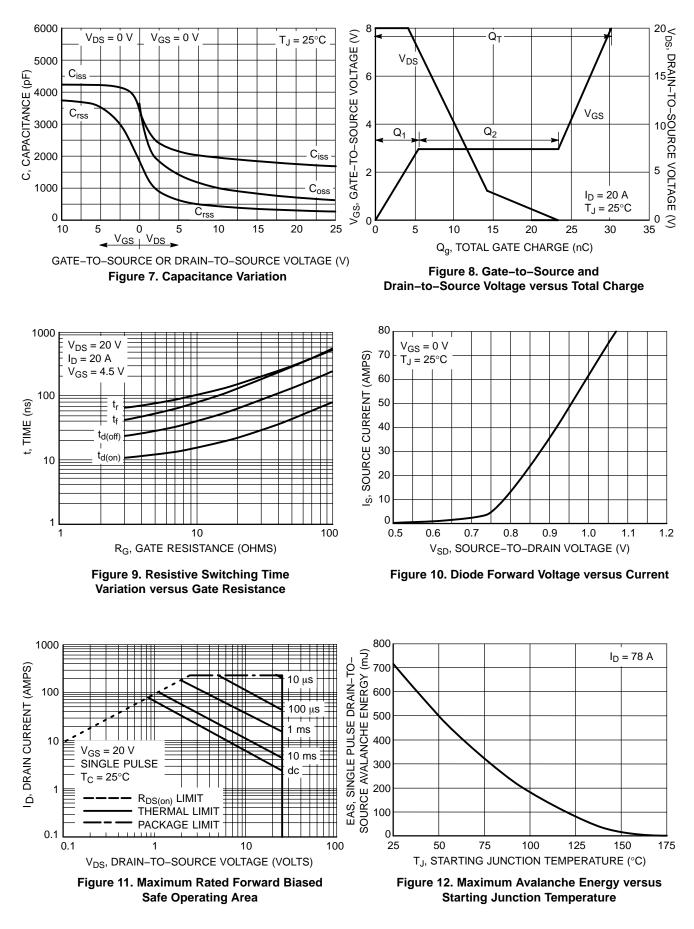
See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 V, I_{C}$	<sub>0</sub> = 250 μA	25			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				24		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V,$	T <sub>J</sub> = 25°C			1.5	μΑ
		$V_{DS} = 20 V$	T <sub>J</sub> = 125°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{C}$	<sub>S</sub> = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{I}$	<sub>D</sub> = 250 μA	1.0	1.6	3.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-5.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V,	I <sub>D</sub> = 78 A		4.6	6.0	mΩ
		V <sub>GS</sub> = 4.5 V,	I <sub>D</sub> = 36 A		6.5	7.8	
Forward Transconductance	gFS	V <sub>DS</sub> = 10 V,	I <sub>D</sub> = 15 A		22		S
CHARGES, CAPACITANCES AND GATE RE	SISTANCE						
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 12 V			1920	2250	
Output Capacitance	C <sub>oss</sub>				960		pF
Reverse Transfer Capacitance	C <sub>rss</sub>	- • • • • • • • • • • •	•		420		1
Total Gate Charge	Q <sub>G(TOT)</sub>				25.5	35	
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 20 \text{ V},$ $I_D = 20 \text{ A}$			2.4		nC
Gate-to-Source Charge	Q <sub>GS</sub>				5.3		
Gate-to-Drain Charge	Q <sub>GD</sub>				18.2		
SWITCHING CHARACTERISTICS (Note 4)						•	
Turn–On Delay Time	t <sub>d(on)</sub>				11		- ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V	/ns = 20 V.		68		
Turn–Off Delay Time	t <sub>d(off)</sub>	I <sub>D</sub> = 20 A, R			23		
Fall Time	t <sub>f</sub>				42		
DRAIN-SOURCE DIODE CHARACTERISTIC	s						
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$		0.83	1.0	V
		$I_{\rm S} = 20  {\rm A}$	T <sub>J</sub> = 125°C		0.7		
Reverse Recovery Time	t <sub>RR</sub>				39		
Charge Time	ta	$V_{GS} = 0 V$ , dls/d <sub>t</sub> = 100 A/µs, I <sub>S</sub> = 20 A			17.8		ns
Discharge Time	tb				21		
Reverse Recovery Time	Q <sub>RR</sub>				33		nC
PACKAGE PARASITIC VALUES	•				•		•
Source Inductance	L <sub>S</sub>	- Ta = 25C			2.49		
Drain Inductance	L <sub>D</sub>				0.02		nH
Gate Inductance	L <sub>G</sub>				3.46		
Gate Resistance	R <sub>G</sub>				1.0		Ω

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.





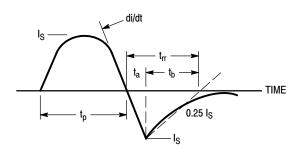


Figure 13. Diode Reverse Recovery Waveform

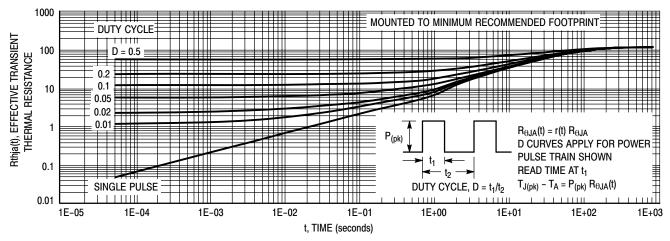


Figure 14. Thermal Response – Various Duty Cycles

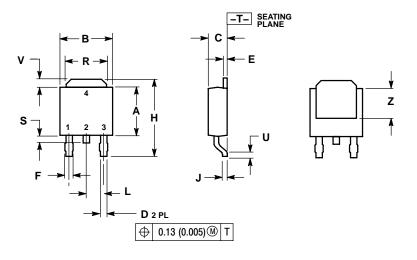
#### **ORDERING INFORMATION**

Order Number	Package	Shipping <sup>†</sup>	
NTD78N03	DPAK	75 Units/Rail	
NTD78N03G	DPAK (Pb-Free)	75 Units/Rail	
NTD78N03T4	DPAK		
NTD78N03T4G	DPAK (Pb-Free)	2500 Tape & Reel	
NTD78N03-1	DPAK Straight Lead	75 Units/Rail	
NTD78N03-1G	DPAK Straight Lead (Pb-Free)		
NTD78N03-35	DPAK-3 Straight Lead (3.5 ± 0.15 mm)		
NTD78N03-35G	DPAK-3 Straight Lead (3.5 $\pm$ 0.15 mm) (Pb-Free)	75 Units/Rail	

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

**DPAK (SINGLE GUAGE)** CASE 369AA-01 **ISSUE A** 

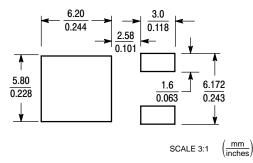


NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.025	0.035	0.63	0.89
Е	0.018	0.024	0.46	0.61
F	0.030	0.045	0.77	1.14
Н	0.386	0.410	9.80	10.40
J	0.018	0.023	0.46	0.58
L	0.090	BSC	2.29	BSC
R	0.180	0.215	4.57	5.45
S	0.024	0.040	0.60	1.01
U	0.020		0.51	
٧	0.035	0.050	0.89	1.27
Ζ	0.155		3.93	

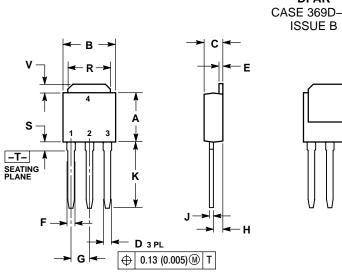
STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

**SOLDERING FOOTPRINT\*** 



\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS



DPAK CASE 369D-01

Ζ

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090 BSC		2.29 BSC	
н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
к	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
V	0.035	0.050	0.89	1.27
Ζ	0.155		3.93	

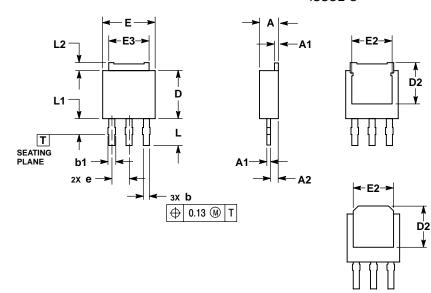
STYLE 2:

PIN 1. GATE 2. DRAIN

3 SOURCE

4 DRAIN

3.5 MM IPAK, STRAIGHT LEAD CASE 369AD-01 ISSUE O



- NOTES: 1.. DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: MILLIMETERS. 3. DIMENSION & APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30mm FROM TERMINAL TIP.
- 4 DIMENSIONS D AND E DO NOT INCLUDE MOLD GATE OR MOLD FLASH.

	MILLIMETERS		
DIM	MIN	MAX	
Α	2.19	2.38	
A1	0.46	0.60	
A2	0.87	1.10	
b	0.69	0.89	
b1	0.77	1.10	
D	5.97	6.22	
D2	4.80		
E	6.35	6.73	
E2	4.70		
E3	4.45	5.46	
е	2.28 BSC		
L	3.40	3.60	
L1		2.10	
L2	0.89	1.27	
62	0.05	1.21	

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